

Search Notes

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Applicant(s)/Patent under
Reexamination

SZYSZKO, JACEK

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
713	168	2/4/2006	ECT

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES, NPL	2/4/2006	ECT